Notice of References Cited Application/Control No. 10/520,731 Examiner Paul lp Application/Control No. Applicant(s)/Patent Under Reexamination SATO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0201747	10-2003	Chaffee, Mark A.	318/630
*	В	US-2003/0199997	10-2003	Gao, Zhiqiang	700/18
*	C	US-2002/0176201	11-2002	Hsin et al.	360/78.05
*	D	US-2002/0156541	10-2002	Yutkowitz, Stephen J.	700/28
*	Ε	US-2002/0153857	10-2002	lwaji et al.	318/700
*	F	US-2002/0022903	02-2002	Krah et al.	700/170
*	G	US-2002/0019715	02-2002	Cohen et al.	702/75
*	Н	US-7,030,588	04-2006	Tsuruta et al.	318/727
*	-	US-6,710,965	03-2004	Ding et al.	360/77.02
*	J	US-6,650,078	11-2003	Chaffee, Mark A.	318/630
*	К	US-6,622,099	09-2003	Cohen et al.	702/75
*	L	US-5,786,678	07-1998	Kobayashi et al.	318/677
*	М	US-5,301,101	04-1994	MacArthur et al.	700/36

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					·
	s					
	Т					

NON-PATENT DOCUMENTS

	, ,						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	. W						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.